

Search Notes

Application/Control No.

10/798,469

Examiner

VanThu Nguyen

Applicant(s)/Patent under
Reexamination

LEE ET AL.

Art Unit

2824

SEARCHED

Class	Subclass	Date	Examiner
365	189.01 189.04 x 190 x 230.01	11/10/2005	VTN
	230.03 x		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (see print out history)	11/4/2005	VTN